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TEST REPORT

Application No.: SZEM1801000280BA

Applicant:

Address of Applicant:

Manufacturer:

Address of Manufacturer:

Factory:

Address of Factory:

Equipment Under Test (EUT):

EUT Name: POWER BANK

Model No.: P61
Trade mark: hame

Standard(s): 47 CFR Part 15, Subpart B

Date of Receipt: 2018-01-10

Date of Test: 2018-01-11 to 2018-01-12

Date of Issue: 2018-01-30

Test Result: Pass*



EMC Laboratory Manager

The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report. If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system complies with all relevant standards. Any mention of SGS International Electrical Approvals or testing done by SGS International Electrical Approvals in connection with, distribution or use of the product described in this report must be approved by SGS International Electrical Approvals in writing.

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^{*} In the configuration tested, the EUT complied with the standards specified above.





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	Revision Record								
Version	Version Chapter Date Modifier Remark								
01		2018-01-30		Original					

Authorized for issue by:		
	Toychen	
	Foray Chen /Project Engineer	
	EvicFu	
	Eric Fu /Reviewer	



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2 Test Summary

Emission Part								
Item	Standard	Method	Requirement	Result				
Conducted Emissions at Mains Terminals (150kHz-30MHz)	47 CFR Part 15,Subpart B	ANSI C63.4	Class B	Pass				
Radiated Emissions (30MHz-1GHz)	47 CFR Part 15,Subpart B	ANSI C63.4	Class B	Pass				

InternalSource	UpperFrequency
Below 1.705MHz	30MHz
1.705MHz to 108MHz	1GHz
108MHz to 500MHz	2GHz
500MHz to 1GHz	5GHz
Above 1GHz	5th harmonic of the highest frequency or 40GHz, whichever is lower



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4 General Information

4.1 Details of E.U.T.

Power supply:	Micro USB input: DC5V 2.1A
	Type-C input: DC5V 3A
	USB output 1: DC5V 2.4A
	USB output 2: DC5V 1.5A
	Type-C output: DC5V 3A
	Total output: DC5V 3A max
	Rechargeable battery: DC3.7V 6000mAh 22.2Wh
Cable:	USB cable: 20cm unshielded

4.2 Description of Support Units

Description	Manufacturer	Model No.	Serial No.
Adapter	Apple	A1357 W010A051	REF. No.SEA0500
Load Resistor	SGS	N/A	REF. No.SEA0600
USB Cable	PHILIPS	SWR2101	REF. No.SEA0700

4.3 Measurement Uncertainty

No.	Item	Measurement Uncertainty
1	Conduction emission	3.0dB (150kHz to 30MHz)
2	Radiated emission	4.5dB (30MHz-1GHz)
3	Temperature test	1℃
4	Humidity test	3%



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4.4 Test Location

All tests were performed at:

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen Branch

No. 1 Workshop, M-10, Middle Section, Science & Technology Park, Shenzhen, Guangdong, China. 518057.

Tel: +86 755 2601 2053 Fax: +86 755 2671 0594

No tests were sub-contracted.

4.5 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

· CNAS (No. CNAS L2929)

CNAS has accredited SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

A2LA (Certificate No. 3816.01)

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 3816.01.

VCCI

The 3m Fully-anechoic chamber for above 1GHz, 10m Semi-anechoic chamber for below 1GHz, Shielded Room for Mains Port Conducted Interference Measurement and Telecommunication Port Conducted Interference Measurement of SGS-CSTC Standards Technical Services Co., Ltd. have been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-20026, R-14188, C-12383 and T-11153 respectively.

FCC –Designation Number: CN1178

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been recognized as an accredited testing laboratory.

Designation Number: CN1178. Test Firm Registration Number: 406779.

Industry Canada (IC)

Two 3m Semi-anechoic chambers and the 10m Semi-anechoic chamber of SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab have been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 4620C-1, 4620C-2, 4620C-3.

4.6 Deviation from Standards

None

4.7 Abnormalities from Standard Conditions

None



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5 Equipment List

Conducted Emissions at Mains Terminals (150kHz-30MHz)									
Equipment Manufacturer Model No Inventory No Cal Date Cal Du									
Shielding Room	ChangZhou ZhongYu	GB-88	SEM001-06	2017-05-10	2018-05-09				
Measurement Software	AUDIX	e3 V5.4.1221d	N/A	N/A	N/A				
Coaxial Cable	SGS	N/A	SEM024-01	2017-07-13	2018-07-12				
LISN	Rohde & Schwarz	ENV216	SEM007-01	2017-09-27	2018-09-26				
LISN	ETS-LINDGREN	3816/2	SEM007-02	2017-04-14	2018-04-13				
EMI Test Receiver	Rohde & Schwarz	ESCI	SEM004-02	2017-04-14	2018-04-13				

Radiated Emissions (30MHz-1GHz)								
Equipment	Manufacturer	Model No Inventory I		Cal Date	Cal Due Date			
3m Semi-Anechoic Chamber	ETS-LINDGREN	N/A	SEM001-01	2017-08-05	2020-08-04			
Measurement Software	AUDIX	e3 V8.2014-6- 27	N/A	N/A	N/A			
Coaxial Cable	SGS	N/A	SEM025-01	2017-07-13	2018-07-12			
EMI Test Receiver	Agilent Technologies	N9038A	SEM004-05	2017-09-27	2018-09-26			
BiConiLog Antenna (26-3000MHz)	ETS-LINDGREN	3142C	SEM003-01	2017-06-27	2020-06-26			
Pre-amplifier (0.1-1300MHz)	Agilent Technologies	8447D	SEM005-01	2017-04-14	2018-04-13			

General used equipmen	t				
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date
Humidity/ Temperature Indicator	Shanghai Meteorological Industry Factory	ZJ1-2B	SEM002-03	2017-09-29	2018-09-28
Humidity/ Temperature Indicator	Shanghai Meteorological Industry Factory	ZJ1-2B	SEM002-04	2017-09-29	2018-09-28
Humidity/ Temperature Indicator	Mingle	N/A	SEM002-08	2017-09-29	2018-09-28
Barometer	Changchun Meteorological Industry Factory	DYM3	SEM002-01	2017-04-18	2018-04-17



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6 Emission Test Results

6.1 Conducted Emissions at Mains Terminals (150kHz-30MHz)

Test Requirement: 47 CFR Part 15, Subpart B

Test Method: ANSI C63.4 Frequency Range: 150kHz to 30MHz

Limit:

0.15M-0.5MHz 66dB(μ V)-56dB(μ V) quasi-peak, 56dB(μ V)-46dB(μ V) average

0.5M-5MHz 56dB(μ V) quasi-peak, 46dB(μ V) average 5M-30MHz 60dB(μ V) quasi-peak, 50dB(μ V) average

Detector: Peak for pre-scan (9kHz resolution bandwidth) 0.15M to 30MHz

6.1.1 E.U.T. Operation

Operating Environment:

Temperature: 22.2 °C Humidity: 25.8 % RH Atmospheric Pressure: 1020 mbar

Pretest these mode to find the worst case:

a: Micro USB charge mode, keep EUT being charged with adapter. b: Type-C charge mode, keep EUT being charged with adapter.

d: Micro USB charge and discharge mode, keep EUT being charged with adapter

and working with full load.

e: Type-C charge and discharge mode, keep EUT being charged with adapter and

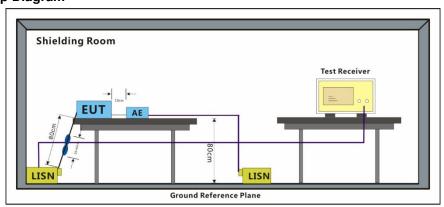
working with full load.

The worst case

d: Micro USB charge and discharge mode, keep EUT being charged with adapter

for final test: and working with full load.

6.1.2 Test Setup Diagram



6.1.3 Measurement Data

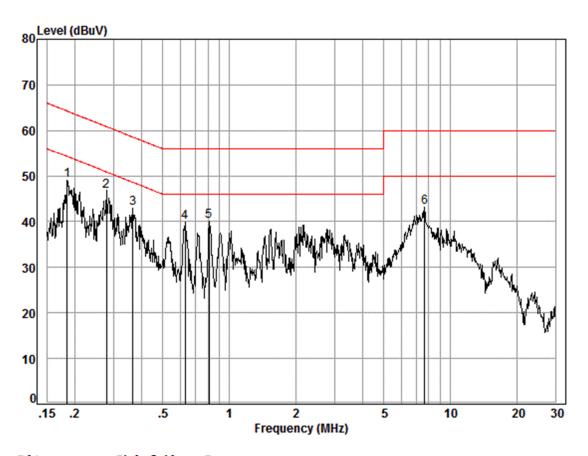
An initial pre-scan was performed with peak detector. Quasi-Peak or Average measurement were performed at the frequencies with maximized peak emission were detected.



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Mode:d; Line:Live Line



Site : Shielding Room

Condition: Line Job No. : 00280BA

Test mode: d

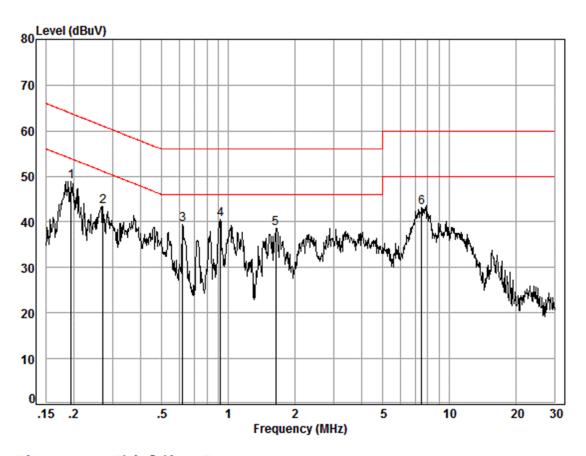
		Cable	LISN	Read		Limit	0ver	
	Freq	Loss	Factor	Level	Level	Line	Limit	Remark
	MHz	dB	dB	dBuV	dBuV	dBuV	dB	
	0.40		0.54	20.45		54.00	5 30	
1	0.18	0.02	9.51	39.45	48.98	54.28	-5.30	Peak
2	0.28	0.01	9.51	37.17	46.69	50.85	-4.16	Peak
3	0.37	0.01	9.50	33.38	42.89	48.56	-5.67	Peak
4	0.63	0.02	9.52	30.31	39.85	46.00	-6.15	Peak
5	0.81	0.02	9.50	30.56	40.08	46.00	-5.92	Peak
6	7.65	0.01	9.60	33.62	43.23	50.00	-6.77	Peak



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Mode:d; Line:Neutral Line



Site : Shielding Room

Condition: Neutral Job No. : 00280BA

Test mode: d

	Freq	Cable Loss	LISN Factor	Read Level		Limit Line	Over Limit	Remark
	MHz	dB	dB	dBuV	dBuV	dBuV	dB	
1	0.19	0.02	9.57	39.18	48.77	53.84	-5.07	Peak
2	0.27	0.01	9.58	33.84	43.43	51.07	-7.64	Peak
3	0.62	0.02	9.62	29.79	39.43	46.00	-6.57	Peak
4	0.92	0.02	9.61	30.84	40.47	46.00	-5.53	Peak
5	1.64	0.02	9.64	28.88	38.54	46.00	-7.46	Peak
6	7.49	0.01	9.73	33.42	43.16	50.00	-6.84	Peak



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6.2 Radiated Emissions (30MHz-1GHz)

Test Requirement: 47 CFR Part 15, Subpart B

Test Method: ANSI C63.4 Frequency Range: 30MHz to 1GHz

Measurement Distance: 3m

Limit:

30 MHz - 88 MHz $40.0 (\text{dB}\mu\text{V/m})$ quasi-peak 88 MHz - 216 MHz $43.5 (\text{dB}\mu\text{V/m})$ quasi-peak $46.0 (\text{dB}\mu\text{V/m})$ quasi-peak 960 MHz - 1000 MHz $54.0 (\text{dB}\mu\text{V/m})$ quasi-peak

Detector: Peak for pre-scan (120kHz resolution bandwidth) 30M to1000MHz



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6.2.1 E.U.T. Operation

Operating Environment:

Temperature: 19.2 °C Humidity: 34 % RH Atmospheric Pressure: 1020 mbar

Pretest these mode to find the worst case:

a: Micro USB charge mode, keep EUT being charged with adapter. b: Type-C charge mode, keep EUT being charged with adapter.

c: Discharge mode, keep EUT working with full load.

d: Micro USB charge and discharge mode, keep EUT being charged with adapter

and working with full load.

e: Type-C charge and discharge mode, keep EUT being charged with adapter and

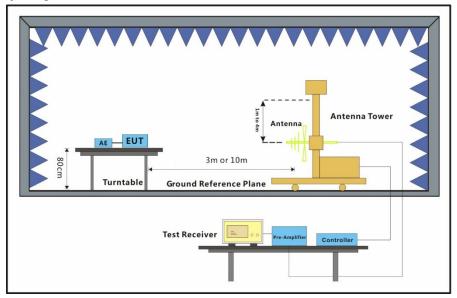
working with full load.

The worst case for final test:

d: Micro USB charge and discharge mode, keep EUT being charged with adapter

and working with full load.

6.2.2 Test Setup Diagram



6.2.3 Measurement Data

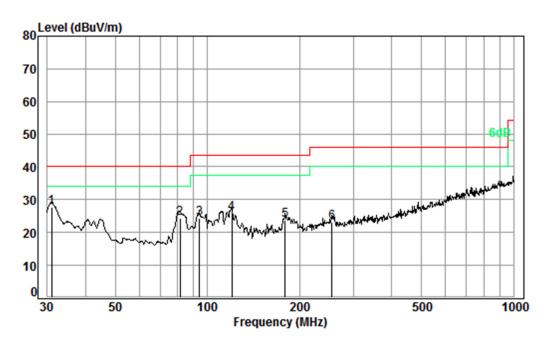
An initial pre-scan was performed in the chamber using the spectrum analyser in peak detection mode. Quasi-peak measurements were conducted based on the peak sweep graph. The EUT was measured by BiConiLog antenna with 2 orthogonal polarities.



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Mode:d; Polarization:Horizontal



Condition: 3m HORIZONTAL

Job No. : 00280BA

Test Mode: d

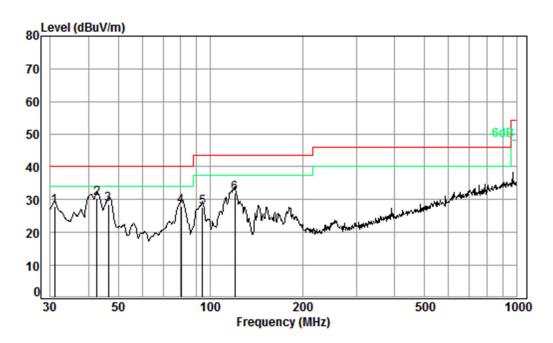
		Cable	Ant	Preamp	Read		Limit	0ver
	Freq	Loss	Factor	Factor	Level	Level	Line	Limit
_								
	MHz	dB	dB/m	dB	dBuV	dBuV/m	dBuV/m	dB
1 pp	30.96	0.60	21.95	27.35	32.37	27.57	40.00	-12.43
2	81.50	1.10	12.17	27.23	38.35	24.39	40.00	-15.61
3	94.10	1.14	13.48	27.21	37.03	24.44	43.50	-19.06
4	120.28	1.25	13.11	27.07	38.42	25.71	43.50	-17.79
5	179.39	1.37	15.89	26.78	33.25	23.73	43.50	-19.77
6	255.62	1.70	19.04	26.52	28.97	23.19	46.00	-22.81



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Mode:d; Polarization:Vertical



Condition: 3m VERTICAL Job No. : 00280BA

Test Mode: d

		Cable	Ant	Preamp	Read		Limit	0ver
	Freq	Loss	Factor	Factor	Level	Level	Line	Limit
_								
	MHz	dB	dB/m	dB	dBuV	dBuV/m	dBuV/m	dB
1	30.96	0.60	21.95	27.35	32.74	27.94	40.00	-12.06
2 pp	42.60	0.66	16.57	27.31	40.45	30.37	40.00	-9.63
3	46.50	0.73	15.27	27.30	39.97	28.67	40.00	-11.33
4	80.36	1.10	12.04	27.23	42.15	28.06	40.00	-11.94
5	94.10	1.14	13.48	27.21	40.14	27.55	43.50	-15.95
6	120.28	1.25	13.11	27.07	44.73	32.02	43.50	-11.48



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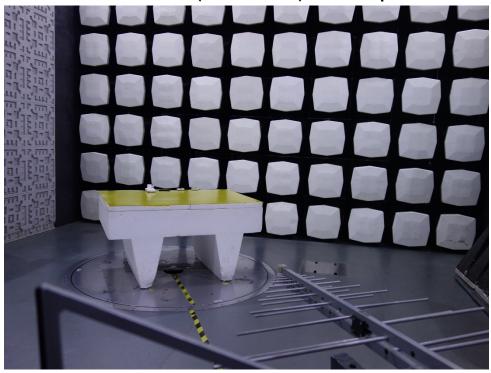
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7 Photographs

7.1 Conducted Emissions at Mains Terminals (150kHz-30MHz) Test Setup



7.2 Radiated Emissions (30MHz-1GHz) Test Setup





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7.3 EUT Constructional Details (EUT Photos)







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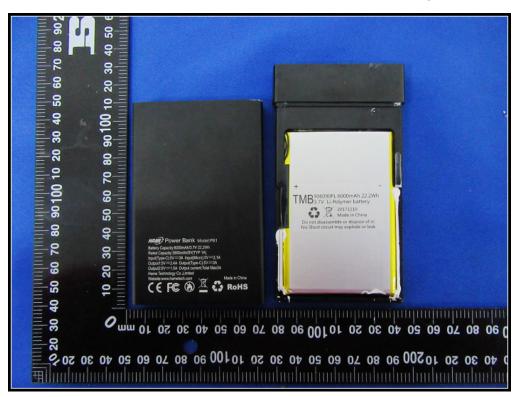


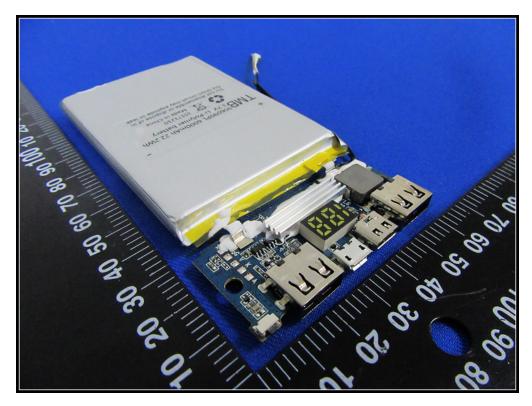




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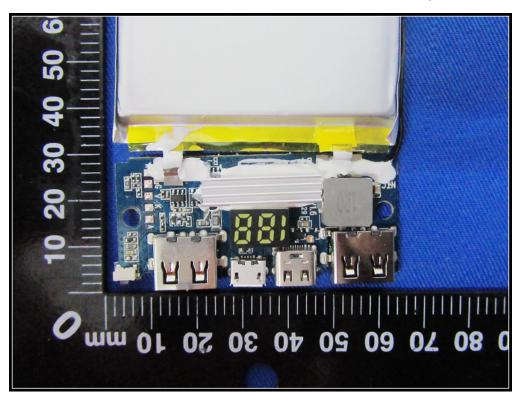


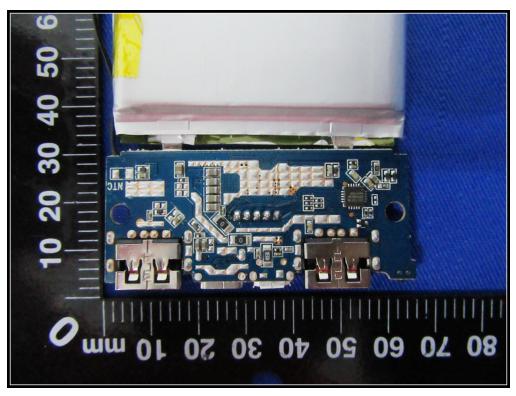




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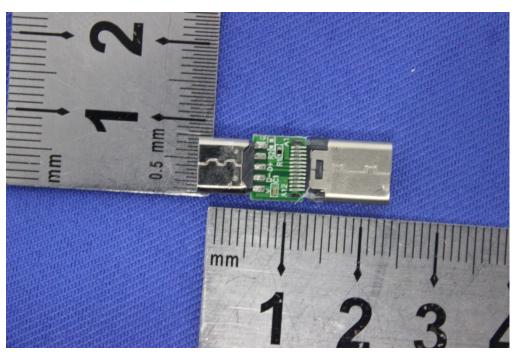




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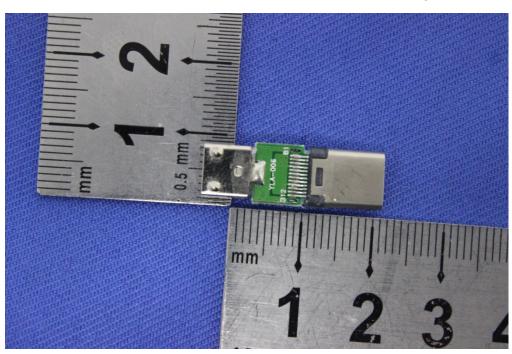






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- End of the Report -